

- 20

Fig. 3

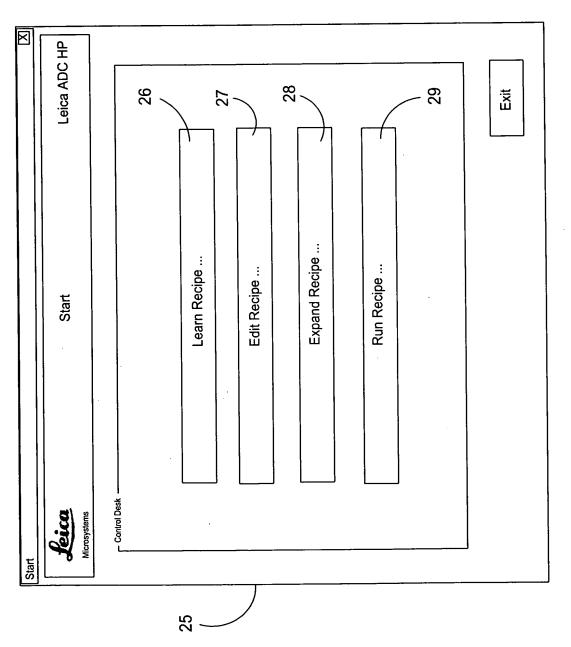
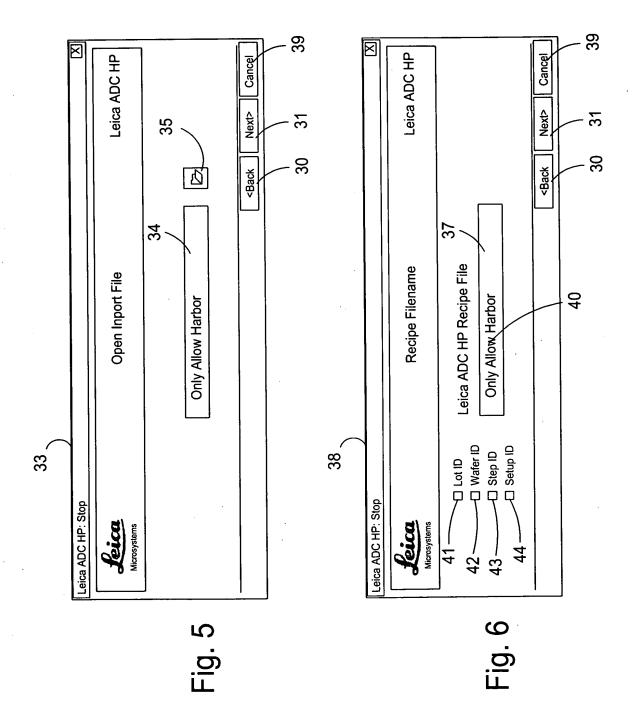
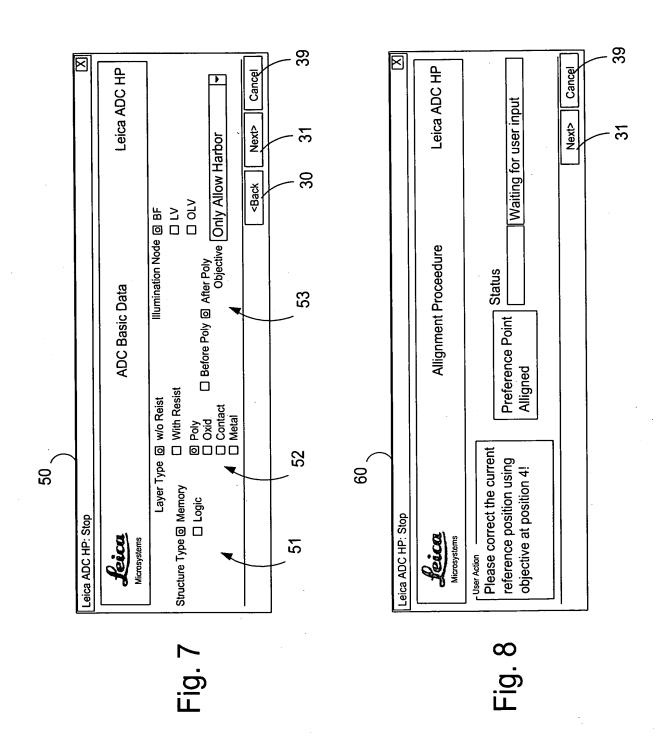
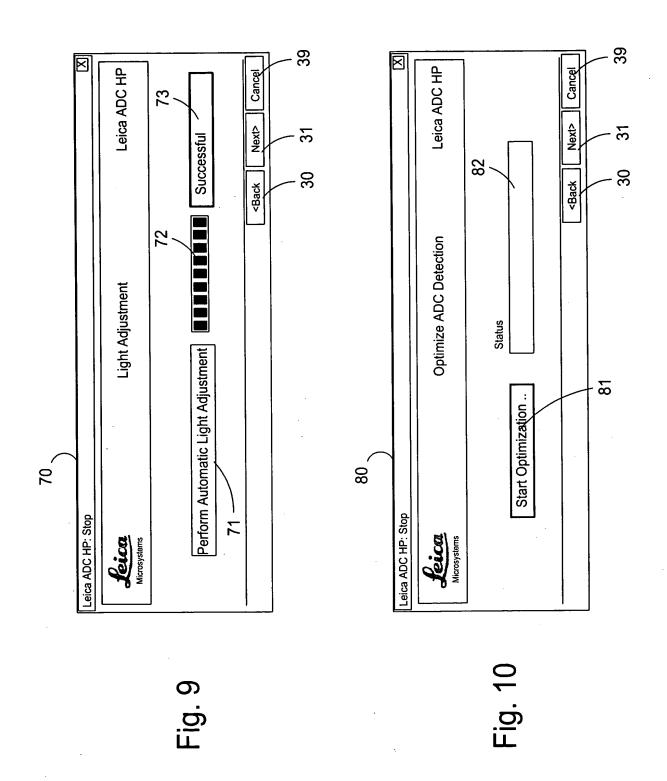
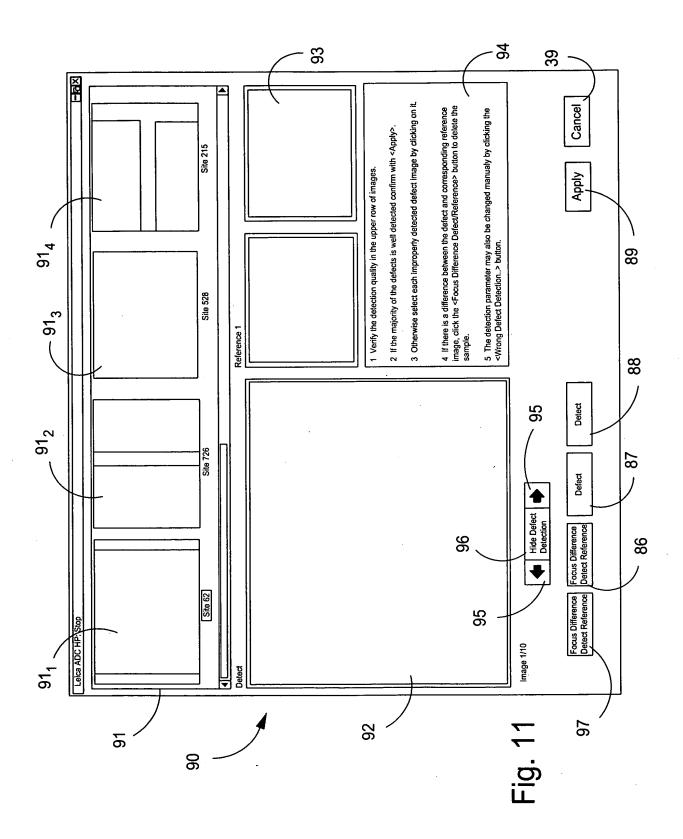


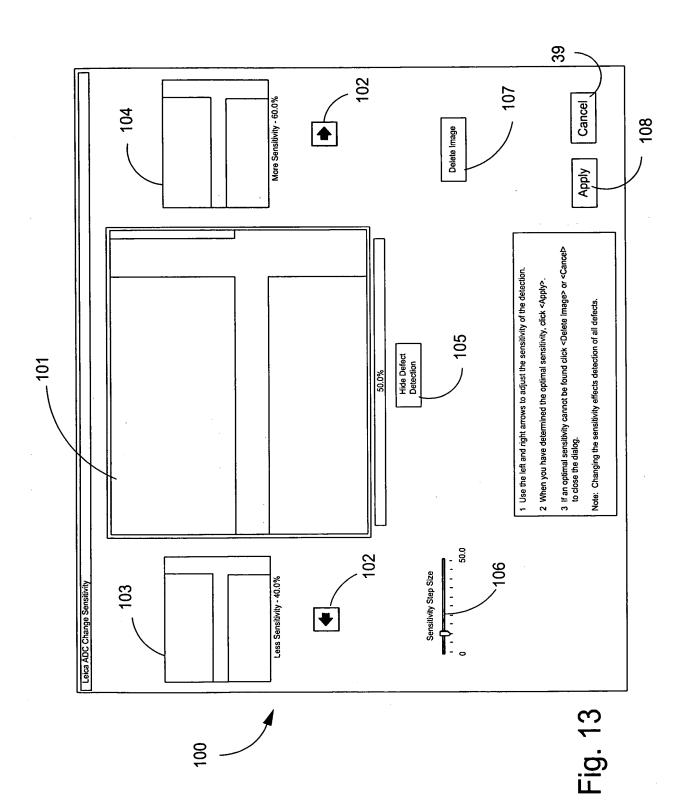
Fig. 4

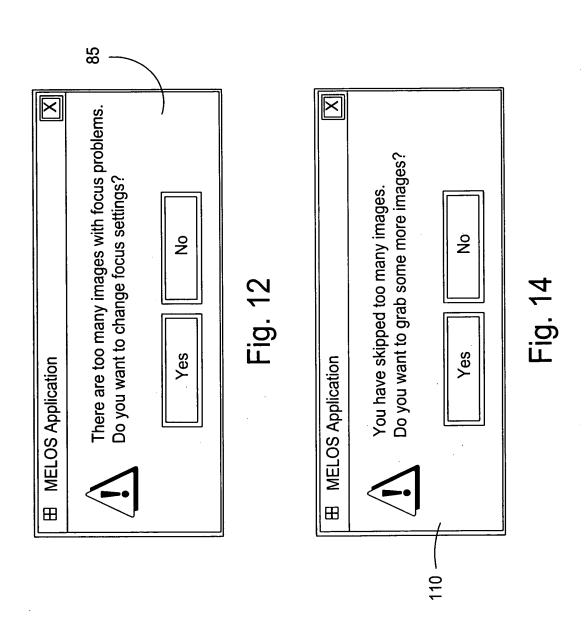


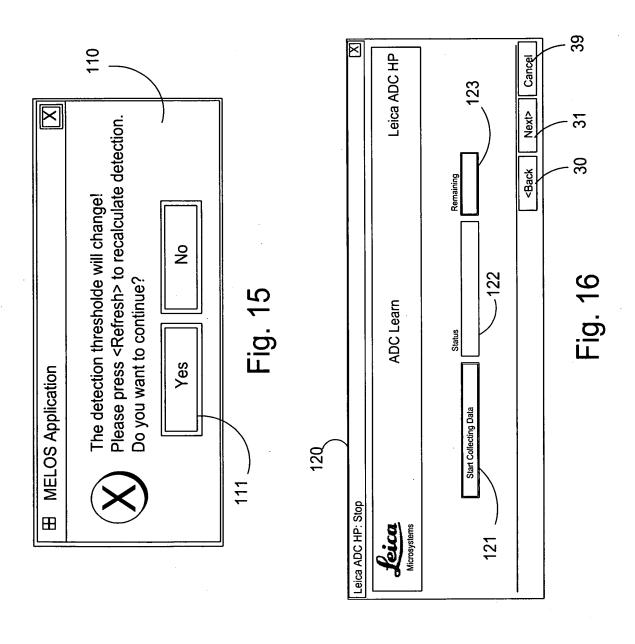


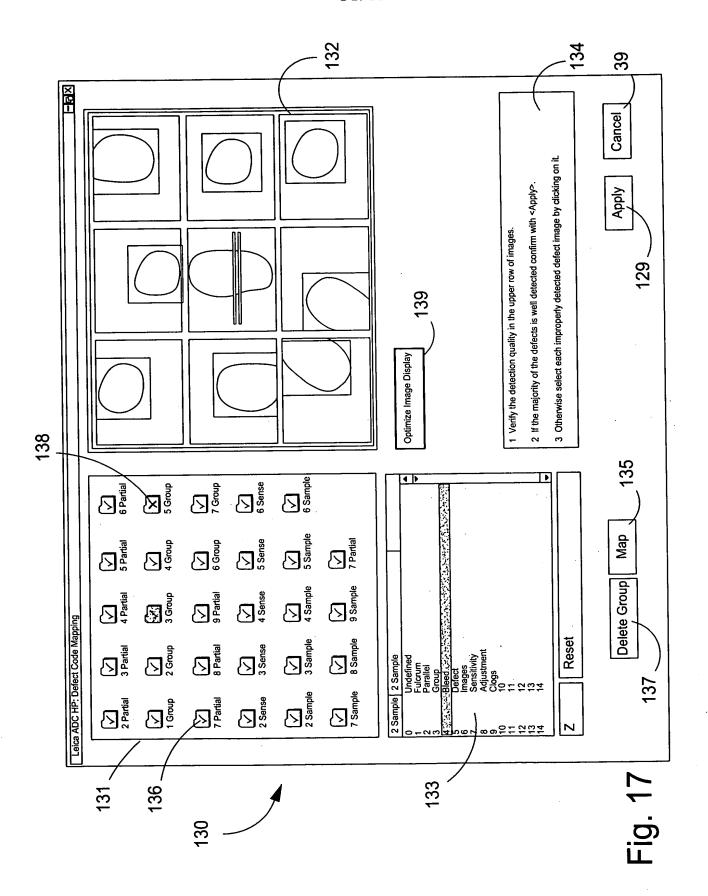


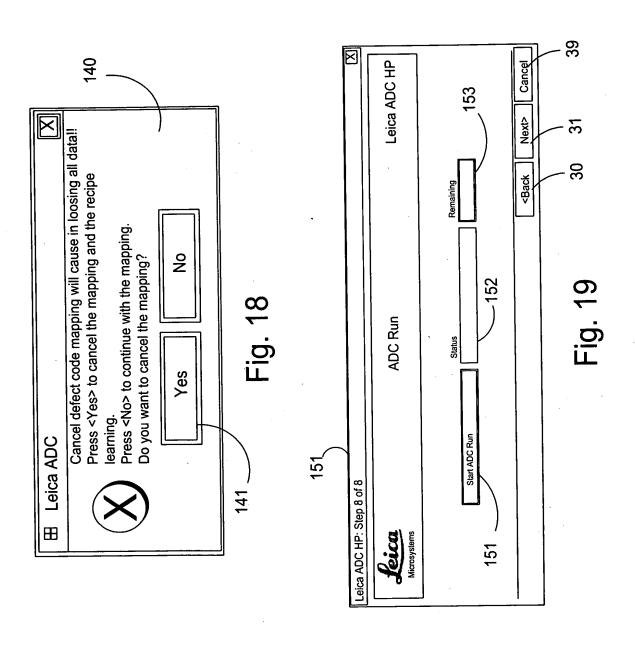












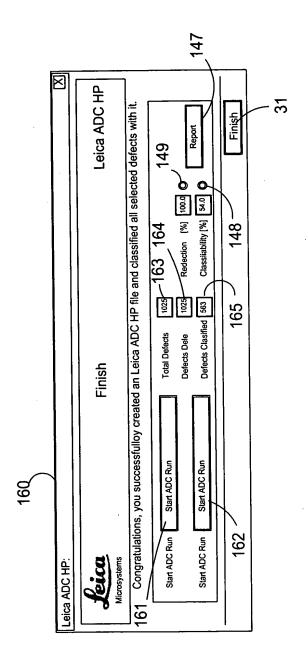
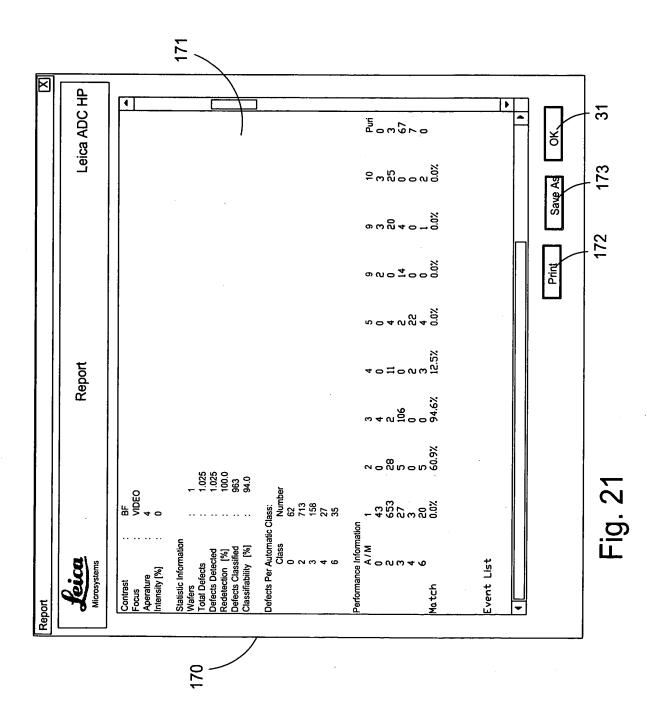


Fig. 20



Easy ADC Relies Files Without Files With Fil			
Argument: File Information: Recipe Information: EasyADC Recipe:			
	Easy ADC Report (Advanced)		
			180
	W:\rogram Files\LEICA-\MEL\Viscon\\\\T\Data\\Review\\K\a\\angle\\Devices\\K\ar\ie		<u> </u>
			_
	W:\Program Files\LEICA-MEL\Viscon\T\Data\Review\LDTB39401X1-POLY1-YD	7	
	W:VProgram Files/LEICA-MELIViscon/NT/Data/Review/Kla\Analog-Devices/KlaFile	\	
Focus: W:\Program Files\LEICA-MEL	W.YProgram Files\LEICA-MELVIsconN \ \ \text{Data\Review\Raynangg-Devices\Raile} \ \ \text{W:\Program Files\LEICA-MEL\VisconNT\Data\Review\LDTB39401X1-PQI_Y1-YD} align*		
e-Base Information:			
st:			
Intensity [%] 85			
Statistic Information:			
Wafers:			
Total Defects: 128			
Classified Defects: N/A			
Defects Detached: N/A			
- 1			
Easy ADC Report (Advanced)	Page 1		

Fig. 22